Search Notes



Application/Control No.	Applicant(s)/Pat Reexamination	ent under
10/736,635	OKAMOTO ET	AL.
Examiner	Art Unit	
Nathan M. Nutter	1711	1 of 2

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Class	Class Subclass		Examiner	
428	423.7	10/13/2004	ТВ	
	423.4			
	495.1			
	480			
528	271, 272			
ABOVE	TO DATE	4/15/2005	NMN	
FULL	TO DATE	4/15/2005	NMN	
528	206, 176			
	180, 190			
	191, 193			
	207, 212			
	218			
525	437, 444			
252	299.62			

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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST Search	10/13/2004	4 TB	
INVENTOR SEARCH	10/13/2004	4 TB	
WEST Search	4/15/2005	, NMN	
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Search Notes (continued)

Application/C	ontrol No.	Applicant(s) Reexaminat	/Patent under ion	
10/736,635		ОКАМОТО	ET AL.	
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Nathan M. N	utter	1711	2 of 2	

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